

# FMS2305A

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# FMS2305A

30V P-Channel Enhancement  
Mode Power MOSFET

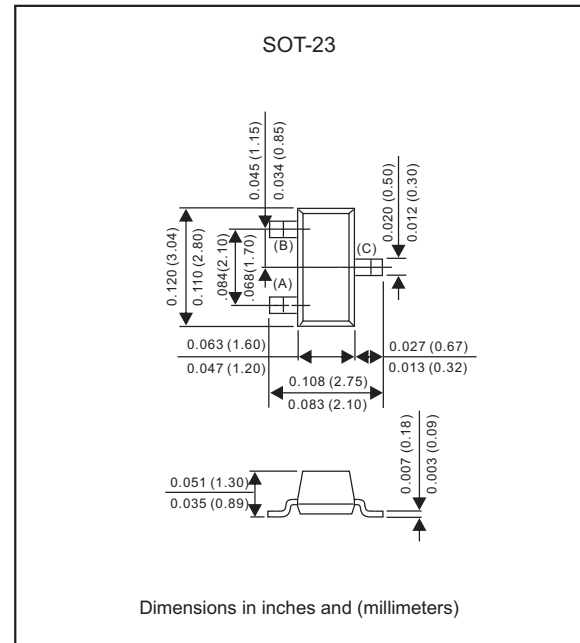
## Package outline

## Features

- Super high dense cell design for low  $R_{DS(ON)}$   
 $R_{DS(ON)} < 60m\Omega @ V_{GS} = -10V$ .
- Rugged and reliable.
- Capable of 2.5V gate drive.
- Simple drive requirement.
- In compliance with EU RoHS 2002/95/EC directives.
- Suffix "-H" indicates Halogen-free part, ex. FMS2305A-H.

## Mechanical data

- Epoxy: UL94-V0 rated flame retardant
- Case : Molded plastic, SOT-23
- Terminals : Solder plated, solderable per  
MIL-STD-750, Method 2026
- Mounting Position : Any
- Weight : Approximated 0.008 gram



## Maximum ratings (AT $T_A = 25^\circ C$ unless otherwise noted)

PARAMETER	CONDITIONS	Symbol	MIN.	TYP.	MAX.	UNIT
Drain-source voltage		$V_{DSS}$			-30	V
Drain current-continue  -pulsed	$(T_A = 25^\circ C)$	$I_D$			-3.2	A
	$(T_A = 70^\circ C)$				-2.6	
		$I_{DM}$			-10	
Gate- source voltage-continue		$V_{GS}$			$\pm 12$	V
Total power dissipation (Derate above $25^\circ C$ )		$P_D$			1.38	W
Junction to ambient thermal resistance		$R_{\theta JA}$			90	$^\circ C/W$
Operation junction temperature		$T_J$	-55		+150	$^\circ C$
Storage temperature		$T_{STG}$	-65		+175	$^\circ C$

## FMS2305A

Electrical characteristics (At  $T_A=25^\circ\text{C}$  unless otherwise noted)

PARAMETER	CONDITIONS	Symbol	MIN.	TYP.	MAX.	UNIT
<b>OFF CHARACTERISTICS</b>						
Drain-source breakdown voltage	$V_{GS} = 0V, I_D = -250\mu A$	$BV_{DSS}$	-30			V
Zero gate voltage drain current	$V_{DS} = -30V, V_{GS} = 0V, T_J = 25^\circ\text{C}$ $V_{DS} = -24V, V_{GS} = 0V, T_J = 70^\circ\text{C}$	$I_{DSS}$			-1.0 -25	$\mu A$
Gate-body leakage current-forward	$V_{GS} = 12V, V_{DS} = 0$	$I_{GSSF}$			100	nA
Gate-body leakage current-reverse	$V_{GS} = -12V, V_{DS} = 0$	$I_{GSSR}$			-100	nA
<b>ON CHARACTERISTICS (Note 1)</b>						
Gate threshold voltage	$V_{DS} = V_{GS}, I_D = -250\mu A$	$V_{GS(th)}$	-0.5			V
Static drain-source on-resistance	$V_{GS} = -10V, I_D = -3.2A$ $V_{GS} = -4.5V, I_D = -3.0A$ $V_{GS} = -2.5V, I_D = -2.0A$ $V_{GS} = -1.8V, I_D = -1.0A$	$R_{DS(on)}$			60 80 150 250	m $\Omega$
Reverse recovery time, Note 1	$V_{GS} = 0, I_S = -1.2A, di/dt = 100A/\mu S$	$T_{rr}$		24		nS
Reverse recovery charge, Note 1	$V_{GS} = 0, I_S = -3.2A, di/dt = 100A/\mu S$	$Q_{rr}$		19		nC
Forward transconductance, Note 1	$V_{DS} = -5V, I_D = -3A^*$	$g_{FS}$		9.0		sec
Forward on voltage, Note 1	$V_{GS} = 0V, I_S = -1.2A, T_J = 25^\circ\text{C}$ ,	$V_{SD}$			-1.2	V
<b>DYNAMIC CHARACTERISTICS</b>						
Input capacitance	$V_{DS} = -25V, V_{GS} = 0V,$ $f = 1.0\text{MHz}$	$C_{ISS}$		735	1325	pF
Output capacitance		$C_{OSS}$		100		
Reverse transfer capacitance		$C_{RSS}$		80		
Total gate charge	$V_{DS} = -24V, I_D = -3.2A$ $V_{GS} = -4.5V$	$Q_G$		10		nC
Gate-source charge		$Q_{GS}$		1.8		
Gate-drain charge		$Q_{GD}$		3.6		
Turn-On Delay Time	$V_{DS} = -15V, R_D = 4.6\Omega, R_G = 3.3\Omega$ $I_D = -3.2A, V_{GS} = -10V$	$T_{D(ON)}$		7.0		ns
Turn-Off Delay Time		$T_R$		15		
		$T_{D(OFF)}$		21		
		$T_F$		15		

Note 1. Pulse duration  $\geq 300\mu s$ , duty cycle 2.0%

2. Pulse width limited by Max. junction temperature

3. Surface mounted on 1 inch square copper pad of FR4 board;  $270^\circ\text{C/W}$  when mounted on min. copper pad.

## Rating and characteristic curves (FMS2305A)

FIG.1 TYPICAL OUTPUT CHARACTERISTIC

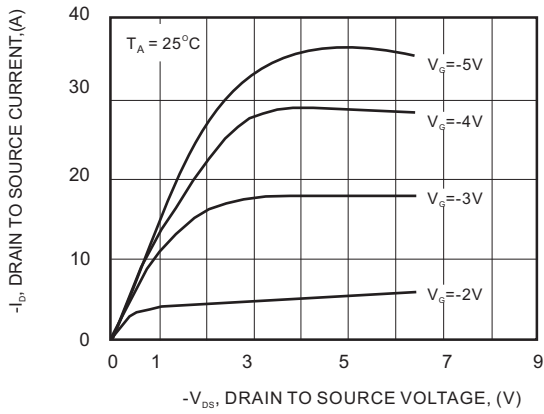


FIG.2 NORMALIZED ON-RESISTANCE

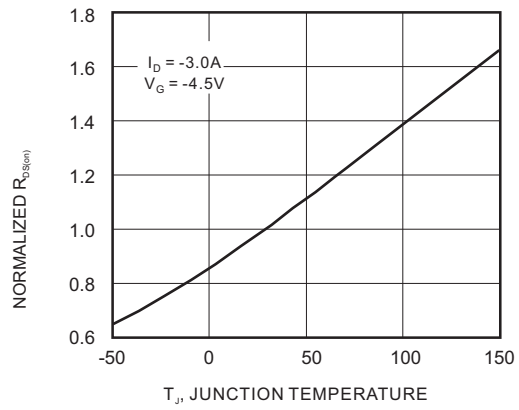


FIG.3 ON RESISTANCE VS GATE VOLTAGE

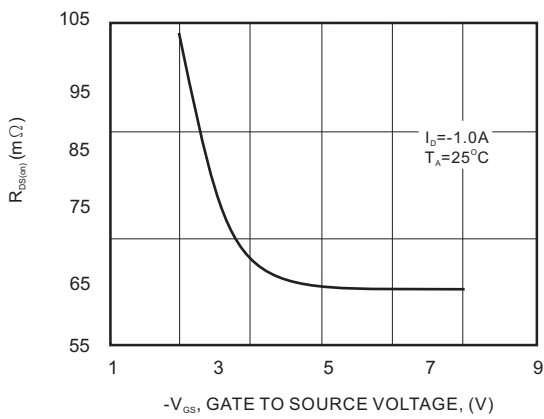


FIG.4 FORWARD CHARACTERISTICS OF REVERSE DIODE

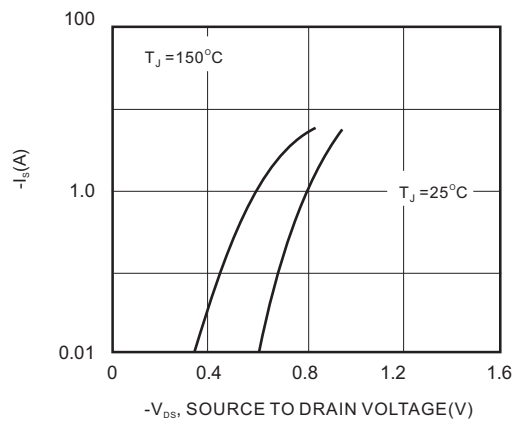
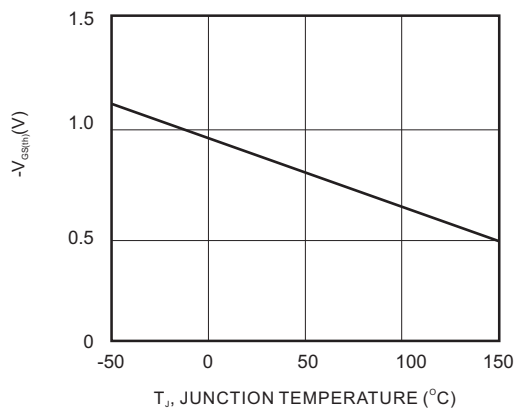


FIG.5 GATE THRESHOLD VOLTAGE VS JUNCTION TEMPERATURE



## Rating and characteristic curves (FMS2305A)

FIG.6 GATE CHARGE WAVEFORM

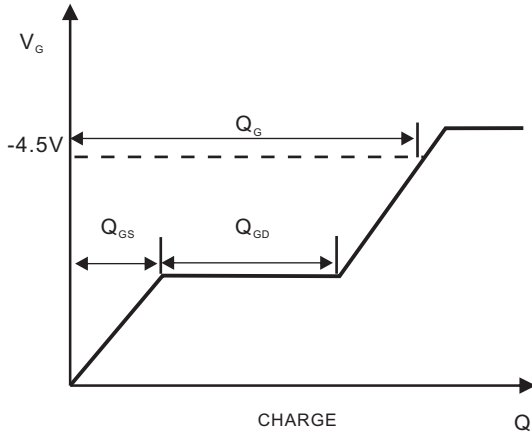


FIG.7 GATE CHARGE

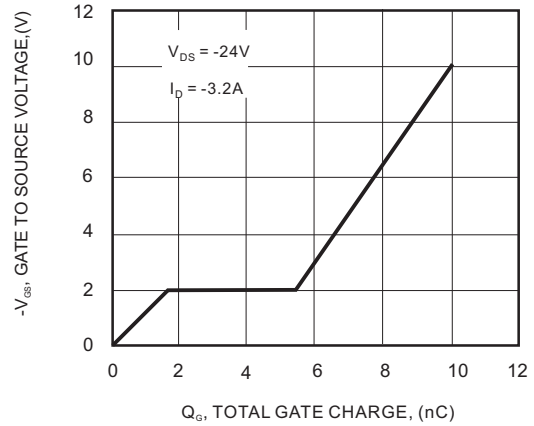


FIG.8 TYPICAL CAPACITANCE CHARACTERISTICS

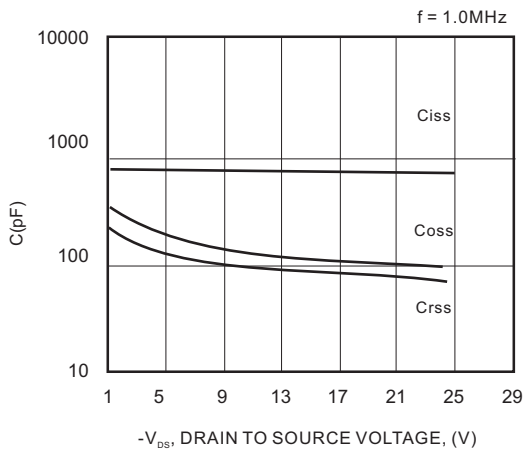


FIG.9 MAXIMUM SAFE OPERATION AREA

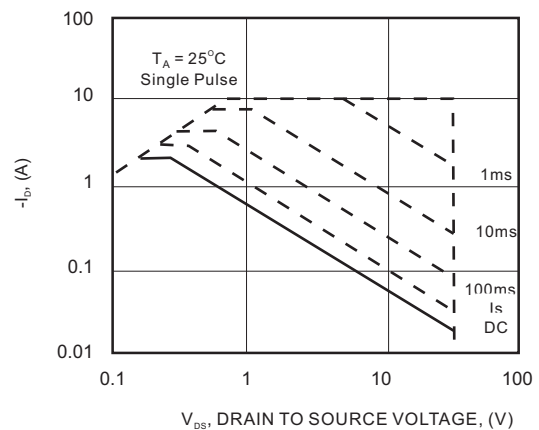


FIG.10 EFFECTIVE TRANSIENT THERMAL IMPEDANCE

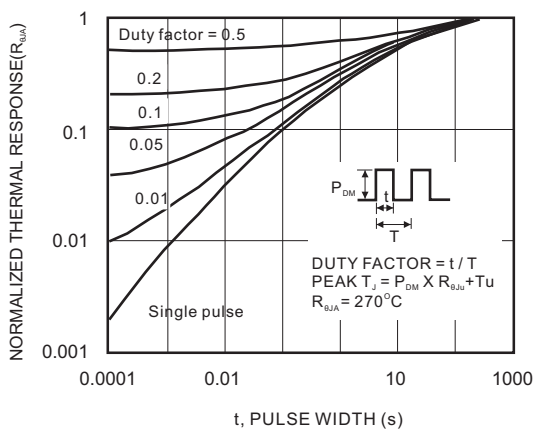
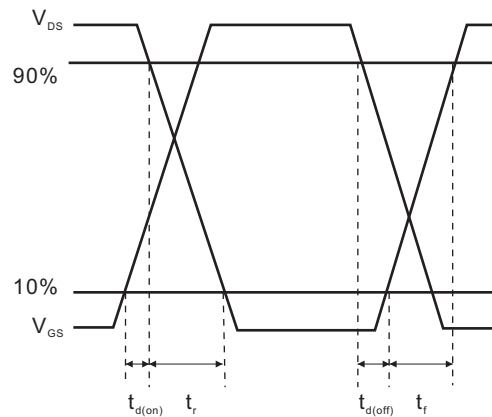
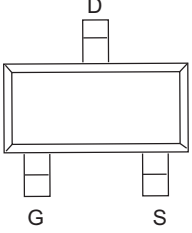
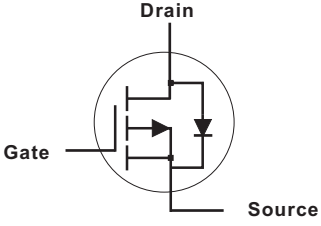


FIG.11 SWITCHING TIME CIRCUIT



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## Pinning information

Pin	Simplified outline	Symbol
PinD Drain PinG Gate PinS Source		

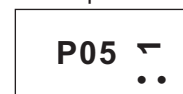
## Marking

Type number	Marking code
FMS2305A	P05 Σ Note 1 ..

Note 1: Σ=Date code

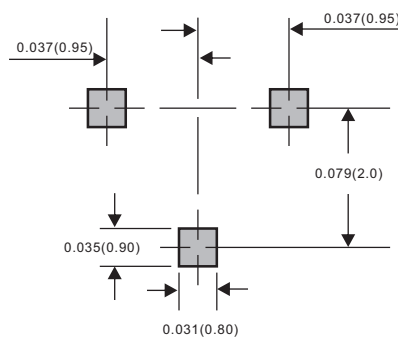
Year \ Month	JAN	FEB	MAR	APR	MAY	JUN	JUL	AUG	SEP	OCT	NOV	DEC
Odd	1	2	3	4	5	6	7	8	9	T	V	C
Even	E	F	H	J	K	L	N	P	U	X	Y	Z

Example:



## Suggested solder pad layout

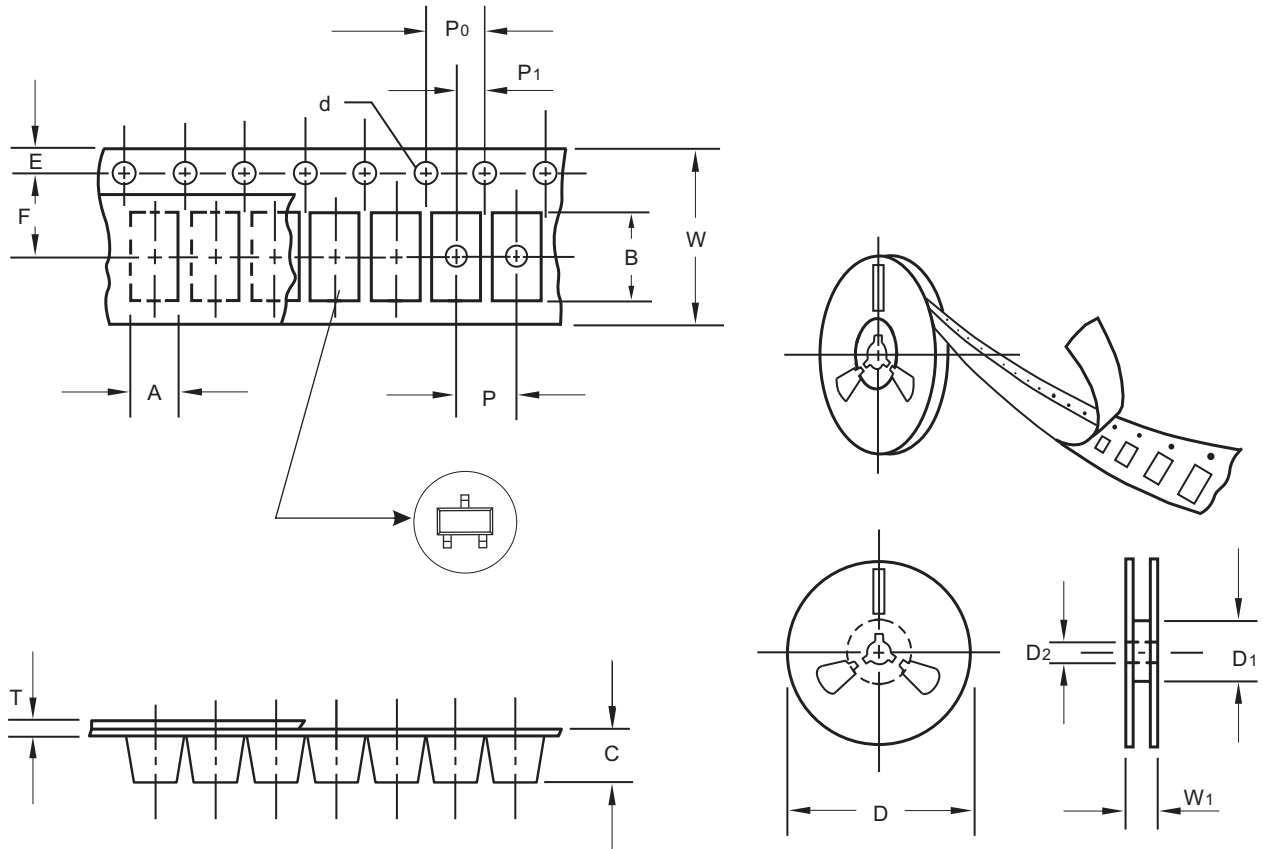
### SOT-23



Dimensions in inches and (millimeters)

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## Packing information



unit:mm

Item	Symbol	Tolerance	SOT-23
Carrier width	A	0.1	3.15
Carrier length	B	0.1	2.77
Carrier depth	C	0.1	1.22
Sprocket hole	d	0.1	1.50
13" Reel outside diameter	D	2.0	-
13" Reel inner diameter	D1	min	-
7" Reel outside diameter	D	2.0	178.00
7" Reel inner diameter	D1	min	55.00
Feed hole diameter	D2	0.5	13.00
Sprocket hole position	E	0.1	1.75
Punch hole position	F	0.1	3.50
Punch hole pitch	P	0.1	4.00
Sprocket hole pitch	P0	0.1	4.00
Embossment center	P1	0.1	2.00
Overall tape thickness	T	0.1	0.23
Tape width	W	0.3	8.00
Reel width	W1	1.0	12.0

Note: Devices are packed in accordance with EIA standard RS-481-A and specifications listed above.

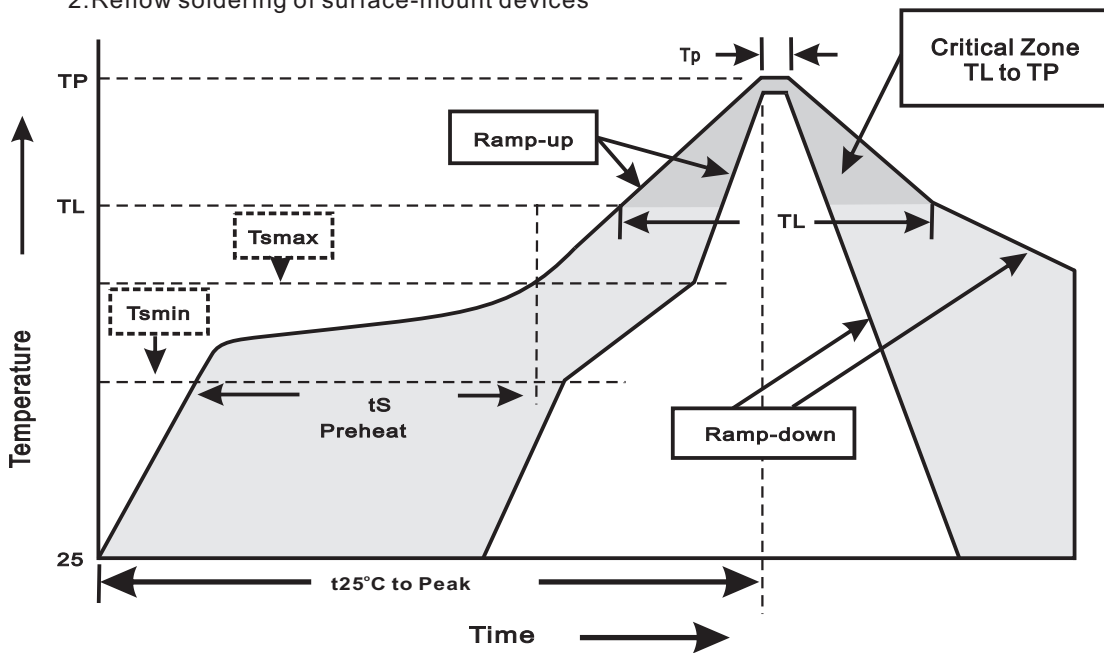
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## Reel packing

PACKAGE	REEL SIZE	REEL (pcs)	COMPONENT SPACING (m/m)	BOX (pcs)	INNER BOX (m/m)	REEL DIA, (m/m)	CARTON SIZE (m/m)	CARTON (pcs)	APPROX. GROSS WEIGHT (kg)
SOT-23	7"	3,000	4.0	30,000	183*183*123	178	382*262*387	240,000	11.6

## Suggested thermal profiles for soldering processes

- 1.Storage environment: Temperature=5°C~40°C Humidity=55%±25%
- 2.Reflow soldering of surface-mount devices



### 3.Reflow soldering

Profile Feature	Soldering Condition
Average ramp-up rate(TL to TP)	<3°C/sec
Preheat -Temperature Min(Tsmin) -Temperature Max(Tsmax) -Time(min to max)(ts)	150°C 200°C 60~120sec
Tsmax to TL -Ramp-upRate	<3°C/sec
Time maintained above: -Temperature(TL) -Time(tL)	217°C 60~260sec
Peak Temperature(TP)	255°C-0/+5°C
Time within 5°C of actual Peak Temperature(tp)	10~30sec
Ramp-down Rate	<6°C/sec
Time 25°C to Peak Temperature	<6minutes



**FMS2305A****High reliability test capabilities**

Item Test	Conditions	Reference
1. Solder Resistance	at $260\pm 5^{\circ}\text{C}$ for $10\pm 2\text{sec}$ . immerse body into solder $1/16''\pm 1/32''$	MIL-STD-750D METHOD-2031
2. Solderability	at $245\pm 5^{\circ}\text{C}$ for 5 sec.	MIL-STD-202F METHOD-208
3. High Temperature Reverse Bias	$V_{DS}=0.8 \times BV_{DSS}$ , $V_{GS}=0\text{V}$ at $T_J=150^{\circ}\text{C}$ for 168 hrs.	MIL-STD-750D METHOD-1026
4. Operation Life Test	Continuous operation at max rated $T_A=25^{\circ}\text{C}$ , $P_C=P_{C(max)}$ for 500hrs.	MIL-STD-750D METHOD-1027
5. Pressure Cooker	$15P_{SIG}$ at $T_A=121^{\circ}\text{C}$ for 4 hrs.	JESD22-A102
6. Temperature Cycling	$-55^{\circ}\text{C}$ to $+125^{\circ}\text{C}$ dwelled for 30 min. and transferred for 5min. total 10 cycles.	MIL-STD-750D METHOD-1051
7. Thermal Shock	$0^{\circ}\text{C}$ for 5 min. rise to $100^{\circ}\text{C}$ for 5 min. total 10 cycles.	MIL-STD-750D METHOD-1056
8. Humidity	at $T_A=85^{\circ}\text{C}$ , RH=85% for 1000hrs.	MIL-STD-750D METHOD-1038
9. High Temperature Storage Life	at $175^{\circ}\text{C}$ for 1000 hrs.	MIL-STD-750D METHOD-1031